

## SANYO Semiconductors **DATA SHEET**

# LC87F2R04A CMOS IC 4K-byte FROM and 128-byte RAM integrated 8-bit 1-chip Microcontroller

#### Overview

The SANYO LC87F2R04A is an 8-bit microcomputer that, centered around a CPU running at a minimum bus cycle time of 83.3ns, integrates on a single chip a number of hardware features such as 4K-byte flash ROM, 128-byte RAM, an Onchip-debugger, sophisticated 16-bit timers/counters (may be divided into 8-bit timers), two 8-bit timers with a prescaler, an asynchronous/synchronous SIO interface, a 12-bit/8-bit 8-channel AD converter, an internal reset and a 12-source 8-vector interrupt feature.

#### **Features**

- ■Flash ROM
  - Capable of on-board programming with wide range (2.2 to 5.5V) of voltage source.
  - Block-erasable in 128 byte units
  - Writable in 2-byte units
  - $4096 \times 8$  bits

#### **■**RAM

- $128 \times 9$  bits
- ■Minimum Bus Cycle
  - 83.3ns (12MHz at V<sub>DD</sub>=2.7V to 5.5V)
  - 100ns (10MHz at V<sub>DD</sub>=2.2V to 5.5V)

Note: The bus cycle time here refers to the ROM read speed.

- \* This product is licensed from Silicon Storage Technology, Inc. (USA), and manufactured and sold by SANYO Semiconductor Co., Ltd.
- Any and all SANYO Semiconductor Co.,Ltd. products described or contained herein are, with regard to "standard application", intended for the use as general electronics equipment (home appliances, AV equipment, communication device, office equipment, industrial equipment etc.). The products mentioned herein shall not be intended for use for any "special application" (medical equipment whose purpose is to sustain life, aerospace instrument, nuclear control device, burning appliances, transportation machine, traffic signal system, safety equipment etc.) that shall require extremely high level of reliability and can directly threaten human lives in case of failure or malfunction of the product or may cause harm to human bodies, nor shall they grant any guarantee thereof. If you should intend to use our products for applications outside the standard applications of our customer who is considering such use and/or outside the scope of our intended standard applications, please consult with us prior to the intended use. If there is no consultation or inquiry before the intended use, our customer shall be solely responsible for the use.
- Specifications of any and all SANYO Semiconductor Co.,Ltd. products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.

#### **SANYO Semiconductor Co., Ltd.**

www.semiconductor-sanyo.com/network

#### ■Minimum Instruction Cycle Time

- 250ns (12MHz at V<sub>DD</sub>=2.7V to 5.5V)
- 300ns (10MHz at V<sub>DD</sub>=2.2V to 5.5V)

#### ■Ports

• Normal withstand voltage I/O ports

Ports whose I/O direction can be designated in 1-bit units 11(P1n, P20, P21, P70)

Ports whose I/O direction can be designated in 4-bit units 8 (P0n)

• Dedicated oscillator ports/input ports 2 (<u>CF1</u>, CF2)

• Reset pin 1 (RES)

• Power pins 2 (V<sub>SS</sub>1, V<sub>DD</sub>1)

#### **■**Timers

• Timer 0: 16-bit timer/counter with a capture register.

Mode 0: 8-bit timer with an 8-bit programmable prescaler (with an 8-bit capture register)  $\times$  2 channels

Mode 1: 8-bit timer with an 8-bit programmable prescaler (with an 8-bit capture register)

+ 8-bit counter (with an 8-bit capture register)

Mode 2: 16-bit timer with an 8-bit programmable prescaler (with a 16-bit capture register)

Mode 3: 16-bit counter (with a 16-bit capture register)

- Timer 6: 8-bit timer with a 6-bit prescaler (with toggle outputs)
- Timer 7: 8-bit timer with a 6-bit prescaler (with toggle outputs)

#### **■**SIO

• SIO1: 8-bit asynchronous/synchronous serial interface

Mode 0: Synchronous 8-bit serial I/O (2- or 3-wire configuration, 2 to 512 tCYC transfer clocks)

Mode 1: Asynchronous serial I/O (half-duplex, 8 data bits, 1 stop bit, 8 to 2048 tCYC baudrates)

Mode 2: Bus mode 1 (start bit, 8 data bits, 2 to 512 tCYC transfer clocks)

Mode 3: Bus mode 2 (start detect, 8 data bits, stop detect)

■AD Converter: 12 bits/8 bits × 8 channels

• 12/8 bits AD converter resolution selectable

- ■Remote Control Receiver Circuit (sharing pins with P73, INT3, and T0IN)
  - Noise rejection function (noise filter time constant selectable from 1 tCYC/32 tCYC/128 tCYC)
- ■Watchdog Timer
  - External RC watchdog timer
  - Interrupt and reset signals selectable

#### **■**Interrupts

- 12 sources, 8 vector addresses
  - 1) Provides three levels (low (L), high (H), and highest (X)) of multiplex interrupt control. Any interrupt requests of the level equal to or lower than the current interrupt are not accepted.
- 2) When interrupt requests to two or more vector addresses occur at the same time, the interrupt of the highest level takes precedence over the other interrupts. For interrupts of the same level, the interrupt into the smallest vector address takes precedence.

No.	Vector Address	Level	Interrupt Source
1	00003H	X or L	INT0
2	0000BH	X or L	INT1
3	00013H	H or L	INT2/T0L/INT4
4	0001BH	H or L	INT3
5	00023H	H or L	тон
6	0002BH	H or L	None
7	00033H	H or L	None
8	0003BH	H or L	SIO1
9	00043H	H or L	ADC/T6/T7
10	0004BH	H or L	Port 0

- Priority levels X > H > L
- Of interrupts of the same level, the one with the smallest vector address takes precedence.
- ■Subroutine Stack Levels: 64levels (The stack is allocated in RAM.)
- ■High-speed Multiplication/Division Instructions

16 bits × 8 bits
24 bits × 16 bits
16 bits ÷ 8 bits
24 bits ÷ 16 bits
16 bits ÷ 8 bits
16 bits ÷ 16 bits
17 tCYC execution time
18 tCYC execution time
19 tCYC execution time
10 tCYC execution time
10 tCYC execution time
10 tCYC execution time
10 tCYC execution time
11 tCYC execution time
12 tCYC execution time
13 tCYC execution time
14 tCYC execution time
15 tCYC execution time
16 tCYC execution time
17 tCYC execution time
18 tCYC execution time
19 tCYC execution time
10 tCYC execution time

#### ■Oscillation Circuits

• Internal oscillation circuits

Medium-speed RC oscillation circuit: For system clock (1MHz)
Multifrequency RC oscillation circuit: For system clock (8MHz)

• External oscillation circuits

Hi-speed CF oscillation circuit: For system clock, with internal Rf

#### ■System Clock Divider Function

- Can run on low current.
- The minimum instruction cycle selectable from 300ns, 600ns, 1.2μs, 2.4μs, 4.8μs, 9.6μs, 19.2μs, 38.4μs, and 76.8μs (at a main clock rate of 10MHz).

#### ■Internal reset function

- Power-on reset (POR) function
  - 1) POR reset is generated only at power-on time.
  - 2) The POR release level can be selected from 8 levels (1.67V, 1.97V, 2.07V, 2.37V, 2.57V, 2.87V, 3.86V, and 4.35V) through option configuration.
- Low-voltage detection reset (LVD) function
  - 1) LVD and POR functions are combined to generate resets when power is turned on and when power voltage falls below a certain level.
  - 2) The use/disuse of the LVD function and the low voltage threshold level (7 levels: 1.91V, 2.01V, 2.31V, 2.51V, 2.81V, 3.79V, 4.28V).

#### ■Standby Function

- HALT mode: Halts instruction execution while allowing the peripheral circuits to continue operation.
  - 1) Oscillation is not halted automatically.
  - 2) There are three ways of resetting the HALT mode.
    - (1) Setting the reset pin to the low level
    - (2) System resetting by watchdog timer or low-voltage detection
    - (3) Occurrence of an interrupt
- HOLD mode: Suspends instruction execution and the operation of the peripheral circuits.
  - 1) The CF, RC and crystal oscillators automatically stop operation.
  - 2) There are four ways of resetting the HOLD mode.
    - (1) Setting the reset pin to the lower level.
    - (2) System resetting by watchdog timer or low-voltage detection
    - (3) Having an interrupt source established at either INT0, INT1, INT2, INT4
    - \* INTO and INT1 HOLD mode reset is available only when level detection is set.
    - (4) Having an interrupt source established at port 0.

#### ■On-chip Debugger

- Supports software debugging with the IC mounted on the target board.
- Software break point setting for debugger.
- Stepwise execution on debugger.
- Real time RAM data monitoring function on debugger.

All the RAM data map can be monitored on screen when the program is running.

(The RAM & SFR data can be changed by screen patch when the program is running)

• Two channels of on-chip debugger pins are available to be compatible with small pin count devices. DBGP0 (P0), DBGP1 (P1)

#### ■Data Security Function (flash versions only)

• Protects the program data stored in flash memory from unauthorized read or copy.

Note: This data security function does not necessarily provide absolute data security.

#### ■Package Form

• MFP24S(300mil): Lead-/Halogen-free type

• SSOP24(225mil): Lead-/Halogen-free type

#### **■**Development Tools

• On-chip debugger: TCB87 TypeB+LC87F2R04A

: TCB87 TypeC (3 wire version) +LC87F2R04A

#### **■**Programming Boards

Package	Programming boards
MFP24S(300mil)	W87F2GM
SSOP24(225mil)	W87F2GS

■Flash ROM Programmer

Maker		Model	Supported Version	Device	
		AF9708			
Flash Support Group, Inc.	Single	AF9709/AF9709B/AF9709C	Rev 03.11 or later	LC87F2L08A	
		(including Ando Electric Co., Ltd. models)			
		AF9723/AF9723B(Main unit)			
(FSG)	Canaad	(including Ando Electric Co., Ltd. models)	-	-	
	Ganged	AF9833(Unit)			
		(including Ando Electric Co., Ltd. models)	-	-	
Flash Support Group, Inc.		AF9101/AF9103(Main unit)			
(FSG)	Onboard	(FSG)	(Note 2)		
+	single/ganged	SIB87(Interface driver)	(Note 2)	-	
SANYO (Note 1)		(SANYO)			
	Cia ala/aan aa d	SKK/SKK Type B	Application version		
Sanyo	Single/ganged	(SANYO FWS)	1.05 or later	LC87F2R04A	
	Onboard	SKK-DBG Type B	Chip data version	LGO/FZRU4A	
	single/ganged	(SANYO FWS)	2.22 or later		

For information about AF-Series:

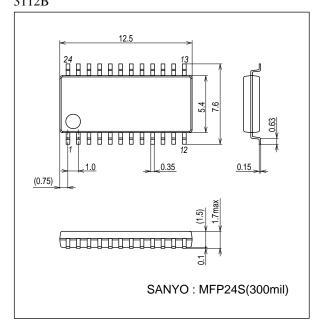
Flash Support Group, Inc. TEL: +81-53-459-1050 E-mail: sales@j-fsg.co.jp

Note1: On-board-programmer from FSG (AF9101/AF9103) and serial interface driver from SANYO (SIB87) together can give a PC-less, standalone on-board-programming capabilities.

Note2: It needs a special programming devices and applications depending on the use of programming environment. Please ask FSG or SANYO for the information.

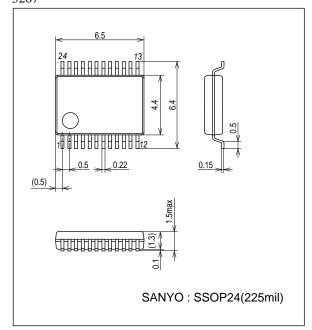
#### **Package Dimensions**

unit : mm (typ) 3112B

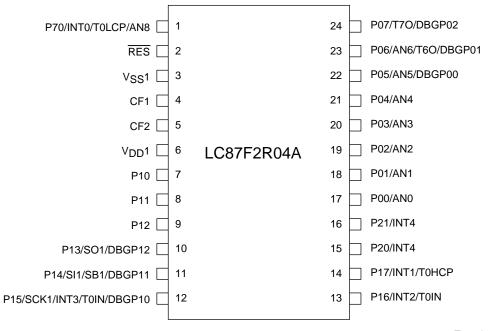


#### **Package Dimensions**

unit : mm (typ) 3287



## **Pin Assignment**



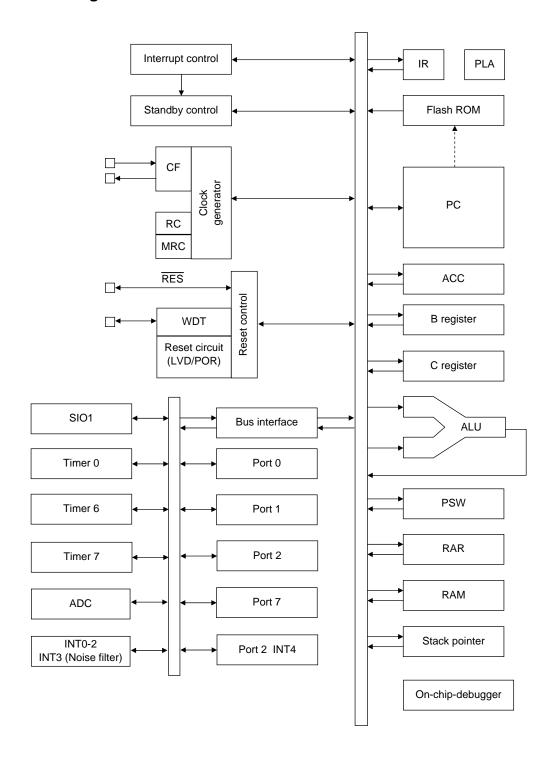
Top view

SANYO: MFP24S(300mil) "Lead-/Halogen-free Type" SANYO: SSOP24(225mil) "Lead-/Halogen-free Type"

MFP24S SSOP24	NAME
1	P70/INT0/T0LCP/AN8
2	RES
3	V <sub>SS</sub> 1
4	CF1
5	CF2
6	V <sub>DD</sub> 1
7	P10
8	P11
9	P12
10	P13/SO1/DBGP12
11	P14/SI1/SB1/DBGP11
12	P15/SCK1/INT3/T0IN/DBGP10

MFP24S SSOP24	NAME		
13	P16/INT2/T0IN		
14	P17/INT1/T0HCP		
15	P20/INT4		
16	P21/INT4		
17	P00/AN0		
18	P01/AN1		
19	P02/AN2		
20	P03/AN3		
21	P04/AN4		
22	P05/AN5/DBGP00		
23	P06/AN6/T6O/DBGP01		
24	P07/T7O/DBGP02		

## **System Block Diagram**



## **Pin Description**

Pin Name	I/O			Des	scription			Option
V <sub>SS</sub> 1	-	- power supply	pins					No
V <sub>DD</sub> 1	-	+ power supply	pin					No
Port 0	I/O	• 8-bit I/O port						
P00 to P07		HOLD reset ir     Port 0 interrup     Pin functions     P06: Timer 6 i     P07: Timer 7 i     P00(AN0) to F	ors can be turned aput ot input toggle output	onverter input				Yes
Port 1	I/O	• 8-bit I/O port	,	, ,	00 1			
P10 to P17		• Pin functions P13: SIO1 dat P14: SIO1 dat P15: SIO1 clo P16: INT2 inp P17: INT1 inp P15(DBGP10)	ors can be turned ta output ta input/bus I/O ck I/O/INT3 inpu	it (with noise filte nput/timer 0 evel nput/timer 0H ca	er)/timer 0 event nt input/timer 0L pture input	· ·	apture input L level	Yes
		INT1	enable	enable	disable	enable	enable	
		INT2	enable	enable	enable	disable	disable	
		INT3	enable	enable	enable	disable	disable	
Port 2 P20 to P21	1/0	• Pin functions P20 to P21: IN	ors can be turned		-bit units.  r OL capture inpu Rising & Falling enable	ut/ timer 0H capt H level disable	ure input  L level  disable	Yes
Port 7	I/O	• 1-bit I/O port						
P70		I/O specifiable     Pull-up resisto     Pin functions     P70: INT0 inp     P70(AN8): AD	ors can be turned	nput/timer 0L ca	-bit units.  pture input/watch  Rising &  Falling	ndog timer outpu H level	t L level	No
		INT0	enable	enable	disable	enable	enable	
						1		
RES	I/O	External reset I	nput/internal res	et output				No
CF1	I	Ceramic resor     Pin function     General-purpor	nator oscillator ir	nput pin				No
CF2	I/O	Ceramic resor     Pin function     General-purpor	nator oscillator o	utput pin				No

#### **Port Output Types**

The table below lists the types of port outputs and the presence/absence of a pull-up resistor.

Data can be read into any input port even if it is in the output mode.

Port Name	Option selected in units of	Option type	Output type	Pull-up resistor
P00 to P07	1 bit	1	CMOS	Programmable (Note 1)
		2	Nch-open drain	No
P10 to P17	1 bit	1	CMOS	Programmable
		2	Nch-open drain	Programmable
P20 to P21	1 bit	1	CMOS	Programmable
		2	Nch-open drain	Programmable
P70	-	No	Nch-open drain	Programmable

Note 1: The control of the presence or absence of the programmable pull-up resistors for port 0 and the switching between low-and high-impedance pull-up connection is exercised in nibble (4-bit) units (P00 to 03 or P04 to 07).

#### **User Option Table**

Option Name	Option Type	Mask version *1	Flash Version	Option Selected in Units of	Option Selection
Port output type	P00 to P07	0	0	1 bit	CMOS
					Nch-open drain
	P10 to P17	0	0	1 bit	CMOS
					Nch-open drain
	P20 to P21	0	0	1 bit	CMOS
					Nch-open drain
Program start	-	×	0	-	00000h
address		*2			01E00h
Low-voltage	Detect function	0	0	-	Enable: Use
detection reset					Disable: Not Used
function	Detect level	0	0	-	7-level
Power-on reset function	Power-On reset level	0	0	-	8-level

<sup>\*1:</sup> Mask option selection-No change possible after mask is completed.

#### **Recommended Unused Pin Connections**

P10 to P17	Recommended Unused Pin Connections				
Port Name	Board	Software			
P00 to P07	Open	Output low			
P10 to P17	Open	Output low			
P20 to P21	Open	Output low			
P70	Open	Output low			
CF1	Pulled low with a $100k\Omega$ resistor or less	General-purpose input port			
CF2	Pulled low with a $100k\Omega$ resistor or less	General-purpose input port			

#### **On-chip Debugger Pin Connection Requirements**

For the treatment of the on-chip debugger pins, refer to the separately available documents entitled "RD87 on-chip debugger installation manual" and "LC872000 series on-chip debugger pin connection requirements"

#### Notes on CF1 and CF2 Pins

• When using as general-purpose input ports Since the CF1 and CF2 pins are configured as CF oscillator pins at system reset time, it is necessary to add a current limiting resistor of  $1k\Omega$  or greater to the CF2 pin in series when using them as general-purpose input pins.

<sup>\*2:</sup> Program start address of the mask version is 00000h.

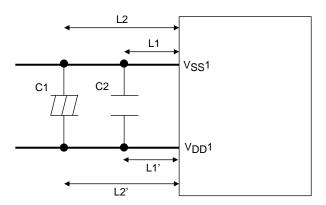
#### Differences between LC872G00 and LC872R00 Series.

		System Reset Time State	After System Reset is Released		
Flash ROM version	CF1/XT1	Set high via the internal Rf resistor	CF oscillation state		
LC87F2G08A	CF2/XT2 Set high  CF1/XT1 Set low via the internal Rf resistor  CF2/XT2 Set low	CF oscillation state			
Mask ROM version	CF1/XT1	Set low via the internal Rf resistor	CF oscillation state		
LC872G08A	CF2/XT2	Set low	CF oscillation state		
Flash ROM version	CF1	Set low via the internal Rf resistor	CF oscillation state		
LC87F2R04A Mask ROM version LC872R04A	CF2	High-impedance (OPEN)	CF oscillation state		

#### Power Pin Treatment Recommendations (VDD1, VSS1)

Connect bypass capacitors that meet the following conditions between the  $V_{\mbox{\scriptsize DD}}1$  and  $V_{\mbox{\scriptsize SS}}1$  pins:

- Connect among the  $V_{DD}1$  and  $V_{SS}1$  pins and bypass capacitors C1 and C2 with the shortest possible heavy lead wires, making sure that the impedances between the both pins and the bypass capacitors are as possible (L1=L1', L2=L2').
- Connect a large-capacity capacitor C1 and a small-capacity capacitor C2 in parallel. The capacitance of C2 should approximately 0.1μF.



## Absolute Maximum Ratings at Ta = 25°C, $V_{SS}1 = 0V$

Dorometer C.		Oh I	Dia /D a see a silva	Conditions		Specification			
	Parameter	Symbol	Pin/Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
	ximum supply tage	V <sub>DD</sub> max	V <sub>DD</sub> 1			-0.3		+6.5	
Inp	ut voltage	VI	CF1, CF2			-0.3		V <sub>DD</sub> +0.3	V
	ut/output tage	V <sub>IO</sub>	Ports 0, 1, 2 P70			-0.3		V <sub>DD</sub> +0.3	
ut	Peak output current	IOPH	Ports 0, 1, 2	CMOS output select Per 1 applicable pin		-10			
High level output current	Mean output current (Note 1-1)	IOMH	Ports 0, 1, 2	CMOS output select Per 1 applicable pin		-7.5			
velo	Total output	ΣΙΟΑΗ(1)	P10 to P14	Total of all applicable pins		-20			
High le	current	ΣΙΟΑΗ(2)	P15 to P17 Ports 0, 2	Total of all applicable pins		-20			
		ΣΙΟΑΗ(3)	Ports 0, 1, 2	Total of all applicable pins		-25			
curre	Peak output current	IOPL(1)	P02 to P07 Ports 1, 2	Per 1 applicable pin				20	
		IOPL(2)	P00, P01	Per 1 applicable pin				30	mA
<b>+</b>		IOPL(3)	P70	Per 1 applicable pin				10	
Low level output current	Mean output current (Note 1-1)	IOML(1)	P02 to P07 Ports 1, 2	Per 1 applicable pin				15	
		IOML(2)	P00, P01	Per 1 applicable pin				20	
e o		IOML(3)	P70	Per 1 applicable pin				7.5	
v le∖	Total output	ΣIOAL(1)	P10 to P14	Total of all applicable pins				50	
Гò	current	ΣIOAL(2)	Ports 0, 2 P15 to P17	Total of all applicable pins				60	
		ΣIOAL(3)	Ports 0, 1, 2	Total of all applicable pins				70	
		ΣIOAL(4)	P70	Total of all applicable pins				7.5	
	wer ssipation	Pd max(1)	MFP24S(300mil))	Ta=-40 to +85°C Package only				129	
		Pd max(2)		Ta=-40 to +85°C Package with thermal resistance board (Note 1-2)				229	
		Pd max(3)	SSOP24(225mil)	Ta=-40 to +85°C Package only				111	mW
		Pd max(4)		Ta=-40 to +85°C Package with thermal resistance board (Note 1-2)				334	
-	erating ambient	Topr				-40		+85	00
	orage ambient	Tstg				-55		+125	°C

Note 1-1: The mean output current is a mean value measured over 100ms.

Note 1-2: SEMI standards thermal resistance board (size: 76.1×114.3×1.6tmm, glass epoxy) is used.

## Allowable Operating Conditions at Ta = -40°C to +85°C, $V_{SS}1 = 0V$

Parameter   Paymbor   Pa					70.70				
Operating   Vpp(I)	Darameter	Cumbal	Din/Domorko	Conditions			Specifi	ication	
Supply voltage   VoD(2)   VoD   VoD   RAM and register contents sustained in HOLD mode.   1.6   Supply voltage   ViH(1)   Ports 1, 2   P77 port input/ interrupt side   ViH(2)   Port 0   2.2 to 5.5   0.3Vpg-0.7   VoD   Vo	Farameter	Symbol	FIII/Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
Memory   VHD   VDD	Operating	V <sub>DD</sub> (1)	V <sub>DD</sub> 1	0.245μs ≤ tCYC ≤ 200μs		2.7		5.5	
Sustaining   Supply voltage   Filiph level   Fili		V <sub>DD</sub> (2)		0.294μs ≤ tCYC ≤ 200μs		2.2		5.5	
Instruction   CFC   CF1   CF2 pin open   CF3 pin	sustaining	VHD	V <sub>DD</sub> 1	<u>-</u>		1.6			
Vi H(3)	=	V <sub>IH</sub> (1)	P70 port input/		2.2 to 5.5	0.3V <sub>DD</sub> +0.7		V <sub>DD</sub>	
timer side   CF   CF   CF   CF   CF   CF   CF   C		V <sub>IH</sub> (2)	Port 0		2.2 to 5.5	0.3V <sub>DD</sub> +0.7		$V_{DD}$	
Low level input voltage   Vi_L(1)		V <sub>IH</sub> (3)	<u> </u>		2.2 to 5.5	0.9V <sub>DD</sub>		$V_{DD}$	V
Low level input voltage   Vil_L(1)		V <sub>IH</sub> (4)	CF1, RES		2.2 to 5.5	0.75V <sub>DD</sub>		VDD	
P70 port input   Interrupt side	Low level		Ports 1, 2,		4.0 to 5.5				
VIL(2)	input voltage				2.2 to 4.0				
Note 2-10   Port 70 watchdog timer side   Port 70 watchdog timer		V <sub>IL</sub> (2)	·		4.0 to 5.5	Vss		0.15V <sub>DD</sub> +0.4	
Note 2-3   Port 70 watchdog timer side   2.2 to 5.5   VSS   0.8VpD-1.0					2.2 to 4.0				
Instruction cycle time (Note 2-1)   Instruction cycle time (Note 2-1)   Instruction cycle time (Note 2-1)   Instruction (Note 2-2)   Instruction (Note 2-3)   Instruction (Note 2-4)   Instruction (Note 2-10 in		V <sub>IL</sub> (3)	_		2.2 to 5.5				
Instruction   CYC   (Note 2-2)   (Note 2-2		V <sub>II</sub> (4)			2.2 to 5.5	Vee		0.25Vnn	
Cycle time (Note 2-1)   Cycle time (Note 2-1)   External system clock frequency   FEXCF   CF1   CF2 pin open   System clock frequency division ratio=1/1   2.2 to 5.5   0.1   10   10   2.2 to 5.5   0.1   10   2.2 to 5.5   0.1   10   2.2 to 5.5   0.1   2.2 to 5.5   0.1   10   2.2 to 5.5   2	Instruction								
FEXCF	-	(Note 2-2)						200	μs
Frequency   Frequency   Fatio=1/1   External system clock duty=50±5%   2.2 to 5.5   0.1   10   MHz	External	FEXCF	CF1	CF2 pin open	2.7 to 5.5	0.1		12	
CF2 pin open	-			ratio=1/1	2.2 to 5.5	0.1		10	
See Fig. 1.   2.7 to 5.5   12				CF2 pin open     System clock frequency division ratio=1/2	3.0 to 5.5	0.2		24.4	MHz
See Fig. 1.   2.2 to 5.5   10		FmCF(1)	CF1, CF2		2.7 to 5.5		12		
FmCF(3)         CF1, CF2         4MHz ceramic oscillation. CF oscillation normal amplifier size selected. (CFLAMP=0) See Fig. 1         2.2 to 5.5         4           4         4         4	-	FmCF(2)	CF1, CF2		2.2 to 5.5		10		
4MHz ceramic oscillation.  CF oscillation low amplifier size selected. (CFLAMP=1) See Fig. 1.  FmMRC  Frequency variable RC oscillation. 1/2 frequency division ration. (RCCTD=0) (Note 2-4)		FmCF(3)	CF1, CF2	CF oscillation normal amplifier size selected. (CFLAMP=0)	2.2 to 5.5		4		
1/2 frequency division ration. 2.7 to 5.5 7.6 8.0 8.4 (RCCTD=0) (Note 2-4)				4MHz ceramic oscillation. CF oscillation low amplifier size selected. (CFLAMP=1)	2.2 to 5.5		4		MHz
FmRC Internal medium-speed RC oscillation 2.2 to 5.5 0.5 1.0 2.0		FmMRC		1/2 frequency division ration.	2.7 to 5.5	7.6	8.0	8.4	
		FmRC		Internal medium-speed RC oscillation	2.2 to 5.5	0.5	1.0	2.0	

Note 2-1: V<sub>DD</sub> must be held greater than or equal to 2.2V in the flash ROM onboard programming mode.

Note 2-4: When switching the system clock, allow an oscillation stabilization time of  $100\mu s$  or longer after the multifrequency RC oscillator circuit transmits from the "oscillation stopped" to "oscillation enabled" state.

Note 2-2: Relationship between tCYC and oscillation frequency is 3/FmCF at a division ratio of 1/1 and 6/FmCF at a division ratio of 1/2.

Note 2-3: See Tables 1 and 2 for the oscillation constants.

## **Electrical Characteristics** at $Ta = -40^{\circ}C$ to $+85^{\circ}C$ , $V_{SS}1 = 0V$

Parameter	Symbol	Pin/Remarks	Conditions			Specifica	ition	
Parameter	Symbol	Pill/Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
High level input current	I <sub>IH</sub> (1)	Ports 0, 1, 2 P70 RES	Output disabled Pull-up resistor off VIN=VDD (Including output Tr's off leakage current)	2.2 to 5.5			1	
	I <sub>IH</sub> (2)	CF1	V <sub>IN</sub> =V <sub>DD</sub>	2.2 to 5.5			15	
Low level input current	I <sub>IL</sub> (1)	Ports 0, 1, 2 P70 RES	Output disabled Pull-up resistor off VIN=VSS (Including output Tr's off leakage current)	2.2 to 5.5	-1			μΑ
	I <sub>IL</sub> (2)	CF1	V <sub>IN</sub> =V <sub>SS</sub>	2.2 to 5.5	-15			
High level output	V <sub>OH</sub> (1)	Ports 0, 1, 2	I <sub>OH</sub> =-1mA	4.5 to 5.5	V <sub>DD</sub> -1			
voltage	V <sub>OH</sub> (2)	]	I <sub>OH</sub> =-0.35mA	2.7 to 5.5	V <sub>DD</sub> -0.4			
	V <sub>OH</sub> (3)		I <sub>OH</sub> =-0.15mA	2.2 to 5.5	V <sub>DD</sub> -0.4			
Low level output	V <sub>OL</sub> (1)	Ports 0, 1, 2	I <sub>OL</sub> =10mA	4.5 to 5.5			1.5	
voltage	V <sub>OL</sub> (2)		I <sub>OL</sub> =1.4mA	2.7 to 5.5			0.4	
	V <sub>OL</sub> (3)		I <sub>OL</sub> =0.8mA	2.2 to 5.5			0.4	V
	V <sub>OL</sub> (4)	P70	I <sub>OL</sub> =1.4mA	2.7 to 5.5			0.4	
	V <sub>OL</sub> (5)		I <sub>OL</sub> =0.8mA	2.2 to 5.5			0.4	
	V <sub>OL</sub> (6)	P00, P01	I <sub>OL</sub> =25mA	4.5 to 5.5			1.5	
	V <sub>OL</sub> (7)		I <sub>OL</sub> =4mA	2.7 to 5.5			0.4	
	V <sub>OL</sub> (8)		I <sub>OL</sub> =2mA	2.2 to 5.5			0.4	
Pull-up resistance	Rpu(1)	Ports 0, 1, 2 P70	V <sub>OH</sub> =0.9V <sub>DD</sub> When Port 0 selected	4.5 to 5.5	15	35	80	
	Rpu(2)	F70	low-impedance pull-up.	2.2 to 4.5	18	50	230	
	Rpu(3)	Port 0	V <sub>OH</sub> =0.9V <sub>DD</sub> When Port 0 selected high-impedance pull-up.	2.2 to 5.5	100	210	400	kΩ
Hysteresis voltage	VHYS(1)	Ports 1, 2		2.7 to 5.5		0.1V <sub>DD</sub>		
	VHYS(2)	P70 RES		2.2 to 5.5		0.07V <sub>DD</sub>		V
Pin capacitance	СР	All pins	For pins other than that under test:  VIN=VSS f=1MHz Ta=25°C	2.2 to 5.5		10		pF

## Serial I/O Characteristics at Ta = -40°C to +85°C, $V_{SS}1 = 0V$ (Note 4)

		Parameter	Symbol	Pin/	Conditions			Spec	ification	
		Parameter	Symbol	Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
	ж	Frequency	tSCK(3)	SCK1(P15)	See Fig. 5.		2			
	Input clock	Low level pulse width	tSCKL(3)			2.2 to 5.5	1			10)(0
Serial clock	u	High level pulse width	tSCKH(3)				1			tCYC
Serial	ock	Frequency	tSCK(4)	SCK1(P15)	CMOS output selected     See Fig. 5.		2			
	Output clock	Low level pulse width	tSCKL(4)			2.2 to 5.5		1/2		tSCK
	ō	High level pulse width	tSCKH(4)					1/2		ISCK
Serial input	Da	ata setup time	tsDI(2)	SB1(P14), SI1(P14)	Must be specified with respect to rising edge of SIOCLK.     See Fig. 5.	004.55	0.05			
Serial	Da	ata hold time	thDI(2)			2.2 to 5.5	0.05			
Serial output	Output delay time		tdD0(4)	SO1(P13), SB1(P14)	Must be specified with respect to falling edge of SIOCLK.     Must be specified as the time to the beginning of output state change in open drain output mode.     See Fig. 5.	2.2 to 5.5			(1/3)tCYC +0.08	μs

Note 4: These specifications are theoretical values. Add margin depending on its use.

## Pulse Input Conditions at Ta = -40°C to +85°C, $V_SS1 = 0V$

Danamatan	O. wash ad	Dia/Damanda	Oditi			Speci	fication	
Parameter	Symbol	Pin/Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
High/low level pulse width	tPIH(1) tPIL(1)	INT0(P70), INT1(P17), INT2(P16), INT4(P20 to P21),	Interrupt source flag can be set.     Event inputs for timer 0 or 1 are enabled.	2.2 to 5.5	1			
	tPIH(2) tPIL(2)	INT3(P15) when noise filter time constant is 1/1	Interrupt source flag can be set.     Event inputs for timer 0 are enabled.	2.2 to 5.5	2			tCYC
	tPIH(3) tPIL(3)	INT3(P15) when noise filter time constant is 1/32	<ul> <li>Interrupt source flag can be set.</li> <li>Event inputs for timer 0 are enabled.</li> </ul>	2.2 to 5.5	64			
	tPIH(4) tPIL(4)	INT3(P15) when noise filter time constant is 1/128	Interrupt source flag can be set.     Event inputs for timer 0 are enabled.	2.2 to 5.5	256			
	tPIL(5)	RES	Resetting is enabled.	2.2 to 5.5	200			μs

#### **AD Converter Characteristics** at $Ta = -40^{\circ}C$ to $+85^{\circ}C$ , $V_{SS}1 = 0V$

#### 12bits AD Converter Mode

Parameter	Cumhal	Pin/Remarks	Conditions			Specific	cation	
Parameter	Symbol	Pin/Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
Resolution	N	AN0(P00) to		2.4 to 5.5		12		bit
Absolute	ET	AN6(P06),	(Note 6-1)	2.7 to 5.5			±16	LSB
accuracy		AN8(P70)		2.4 to 5.5			±20	LOD
Conversion time	TCAD		See Conversion time calculation formulas.	4.0 to 5.5	32		115	
				2.7 to 5.5	64		115	μs
			(Note 6-2)	2.4 to 5.5	410		425	
Analog input voltage range	VAIN			2.4 to 5.5	V <sub>SS</sub>		$V_{DD}$	٧
Analog port	IAINH		VAIN=V <sub>DD</sub>	2.4 to 5.5			1	
input current	IAINL		VAIN=V <sub>SS</sub>	2.4 to 5.5	-1			μА

#### 8bits AD Converter Mode

Danamatan	O. mala al	Pin/Remarks	Conditions		Specification			
Parameter	Symbol	Pili/Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
Resolution	N	AN0(P00) to		2.4 to 5.5		8		bit
Absolute accuracy	ET	AN6(P06) AN8(P70)	(Note 6-1)	2.4 to 5.5			±1.5	LSB
Conversion time	n time TCAD • See Conversion to		See Conversion time calculation	4.0 to 5.5	20		90	
			formulas.	2.7 to 5.5	40		90	μs
			(Note 6-2)	2.4 to 5.5	250		265	
Analog input voltage range	VAIN			2.4 to 5.5	V <sub>SS</sub>		$V_{DD}$	V
Analog port	IAINH	1	VAIN=V <sub>DD</sub>	2.4 to 5.5			1	
input current IAINL		VAIN=V <sub>SS</sub>	2.4 to 5.5	-1			μΑ	

Conversion time calculation formulas:

12bits AD Converter Mode: TCAD(Conversion time) =  $((52/(AD \text{ division ratio}))+2)\times(1/3)\times tCYC$ 8bits AD Converter Mode: TCAD(Conversion time) =  $((32/(AD \text{ division ratio}))+2)\times(1/3)\times tCYC$ 

External oscillation	Operating supply voltage range	System division ratio	Cycle time	AD division ratio	AD conversion time (TCAD)		
(FmCF)	(V <sub>DD</sub> )	(SYSDIV)	(tCYC)	(ADDIV)	12bit AD	8bit AD	
CF-12MHz	4.0V to 5.5V	1/1	250ns	1/8	34.8µs	21.5μs	
CF-12MHZ	3.0V to 5.5V	1/1	250ns	1/16	69.5µs	42.8µs	
CF-10MHz	4.0V to 5.5V	1/1	300ns	1/8	41.8µs	25.8μs	
CF-10IVIEZ	3.0V to 5.5V	1/1	300ns	1/16	83.4µs	51.4μs	
CF-4MHz	3.0V to 5.5V	1/1	750ns	1/8	104.5μs	64.5µs	
GF-4IVIHZ	2.4V to 5.5V	1/1	750ns	1/32	416.5μs	256.5μs	

Note 6-1: The quantization error  $(\pm 1/2LSB)$  must be excluded from the absolute accuracy. The absolute accuracy must be measured in the microcontroller's state in which no I/O operations occur at the pins adjacent to the analog input channel.

Note 6-2: The conversion time refers to the period from the time an instruction for starting a conversion process till the time the conversion results register(s) are loaded with a complete digital conversion value corresponding to the analog input value.

The conversion time is 2 times the normal-time conversion time when:

- The first AD conversion is performed in the 12-bit AD conversion mode after a system reset.
- The first AD conversion is performed after the AD conversion mode is switched from 8-bit to 12-bit conversion mode.

## Power-on Reset (POR) Characteristics at Ta = -40°C to +85°C, $V_{SS}1 = 0V$

					Specif	ication		
Parameter	Symbol	Pin/Remarks	Conditions	Option selected voltage	min	typ	max	unit
POR release	PORRL		Select from option.	1.67V	1.55	1.67	1.79	
voltage			(Note 7-1)	1.97V	1.85	1.97	2.09	
				2.07V	1.95	2.07	2.19	
				2.37V	2.25	2.37	2.49	
				2.57V	2.45	2.57	2.69	
				2.87V	2.75	2.87	2.99	V
				3.86V	3.73	3.86	3.99	
				4.35V	4.21	4.35	4.49	
Detection voltage unknown state	POUKS		• See Fig. 7. (Note 7-2)			0.7	0.95	
Power supply rise time	PORIS		Power supply rise time from 0V to 1.6V.				100	ms

Note7-1: The POR release level can be selected out of 4 levels only when the LVD reset function is disabled.

Note7-2: POR is in an unknown state before transistors start operation.

#### Low Voltage Detection Reset (LVD) Characteristics at Ta = -40°C to +85°C, $V_{SS}1 = 0V$

					Specification			
Parameter	Symbol	Pin/Remarks	Conditions	Option selected voltage	min	typ	max	unit
LVD reset Voltage	LVDET		Select from option.	1.91V	1.81	1.91	2.01	
(Note 8-2)			(Note 8-1)	2.01V	1.91	2.01	2.11	
			(Note 8-3)	2.31V	2.21	2.31	2.41	
			• See Fig. 8.	2.51V	2.41	2.51	2.61	٧
				2.81V	2.71	2.81	2.91	
				3.79V	3.69	3.79	3.89	
				4.28V	4.18	4.28	4.38	
LVD hysteresis	LVHYS			1.91V		55		
width				2.01V		55		
				2.31V		55		
				2.51V		55		mV
				2.81V		60		
				3.79V		65		
				4.28V		65		
Detection voltage unknown state	LVUKS		• See Fig. 8. (Note 8-4)			0.7	0.95	V
Low voltage detection minimum Width (Reply sensitivity)	TLVDW		• LVDET-0.5V • See Fig. 9.		0.2			ms

Note8-1: The LVD reset level can be selected out of 3 levels only when the LVD reset function is enabled.

Note8-2: LVD reset voltage specification values do not include hysteresis voltage.

Note8-3: LVD reset voltage may exceed its specification values when port output state changes and/or when a large current flows through port.

Note8-4: LVD is in an unknown state before transistors start operation.

## Consumption Current Characteristics at Ta = -40 °C to +85 °C, $V_{SS}1 = 0V$

Parameter	Symbol	Pin/	Conditions			Specif	ication	
Farameter	Symbol	Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
Normal mode consumption current	IDDOP(1)	V <sub>DD</sub> 1	FmCF=12MHz ceramic oscillation mode     System clock set to 12MHz side     Internal medium speed RC oscillation	2.7 to 5.5		6.1	10	
(Note 9-1) (Note 9-2)			stopped.  • Frequency variable RC oscillation stopped.  • 1/1 frequency division ratio	2.7 to 3.6		3.7	6.4	
	IDDOP(2)		FmCF=10MHz ceramic oscillation mode     System clock set to 10MHz side     Internal medium speed RC oscillation	2.2 to 5.5		5.3	9.1	
			stopped.  • Frequency variable RC oscillation stopped.  • 1/1 frequency division ratio	2.2 to 3.6		3.4	5.8	
	IDDOP(3)		FmCF=4MHz ceramic oscillation mode     System clock set to 4MHz side     Internal medium speed RC oscillation	2.2 to 5.5		2.6	5.5	
			stopped.  • Frequency variable RC oscillation stopped.  • 1/1 frequency division ratio	2.2 to 3.6		1.9	3.4	
	IDDOP(4)		CF oscillation low amplifier size selected. (CFLAMP=1) FmCF=4MHz ceramic oscillation mode System clock set to 4MHz side	2.2 to 5.5		1.1	2.1	mA
			Internal medium speed RC oscillation stopped.     Frequency variable RC oscillation stopped.     1/4 frequency division ratio	2.2 to 3.6		0.56	1.1	
	IDDOP(5)		External FmCF oscillation stopped.     System clock set to internal medium speed RC oscillation.	2.2 to 5.5		0.47	1.2	
			Frequency variable RC oscillation stopped.     1/2 frequency division ratio	2.2 to 3.6		0.28	0.65	
	IDDOP(6)		External FmCF oscillation stopped.     Internal medium speed RC oscillation stopped.	2.7 to 5.5		4.2	8.1	
			System clock set to 8MHz with frequency variable RC oscillation.(RCCTD=0)     1/1 frequency division ratio.	2.7 to 3.6		3.3	5.6	

Note9-1: Values of the consumption current do not include current that flows into the output transistors and internal pull-up resistors.

Note9-2: The consumption current values do not include operational current of LVD function if not specified.

Continued on next page.

Continued from preceding page.

Continued from		Pin/	Conditions			Specif	ication	
Parameter	Symbol	Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit
HALT mode consumption current (Note 9-1)	IDDHALT(1)	V <sub>DD</sub> 1	HALT mode     FmCF=12MHz ceramic oscillation mode     System clock set to 12MHz side     Internal medium speed RC oscillation	2.7 to 5.5		2.3	4.1	
(Note 9-2)			stopped.  • Frequency variable RC oscillation stopped.  • 1/1 frequency division ratio	2.7 to 3.6		1.2	1.9	
	IDDHALT(2)		HALT mode     FmCF=10MHz ceramic oscillation mode     System clock set to 10MHz side     Internal medium speed RC oscillation	2.2to 5.5		1.9	3.4	
	IDDUM T(s)	-	stopped.  • Frequency variable RC oscillation stopped.  • 1/1 frequency division ratio	2.2 to 3.6		1.0	1.6	
	IDDHALT(3)		HALT mode     FmCF=4MHz ceramic oscillation mode     System clock set to 4MHz side     Internal medium speed RC oscillation	2.2 to 5.5		1.3	2.5	
			stopped.  • Frequency variable RC oscillation stopped.  • 1/1 frequency division ratio	2.2 to 3.6		0.53	1.0	
	IDDHALT(4)		HALT mode     CF oscillation low amplifier size selected.     (CFLAMP=1)     FmCF=4MHz ceramic oscillation mode	2.2 to 5.5		0.80	1.5	mA
			System clock set to 4MHz side     Internal medium speed RC oscillation stopped.     Frequency variable RC oscillation stopped.     1/4 frequency division ratio	2.2 to 3.6		0.31	0.62	
	IDDHALT(5)		HALT mode     External FmCF oscillation stopped.     System clock set to internal medium speed	2.2 to 5.5		0.28	0.73	
			RC oscillation  • Frequency variable RC oscillation stopped.  • 1/2 frequency division ratio	2.2 to 3.6		0.14	0.36	
	IDDHALT(6)		HALT mode     External FmCF oscillation stopped.     Internal medium speed RC oscillation stopped.	2.7 to 5.5		1.3	2.7	
			System clock set to 8MHz with frequency variable RC oscillation. (RCCTD=0)     1/1 frequency division ratio.	2.7 to 3.6		0.93	1.8	
HOLD mode	IDDHOLD(1)	V <sub>DD</sub> 1	HOLD mode	2.2 to 5.5		0.03	25	
consumption current			CF1=V <sub>DD</sub> or open (External clock mode)	2.2 to 3.6		0.02	5.9	
(Note 9-1)	IDDHOLD(2)		HOLD mode	5.0		0.03	1.2	
(Note 9-2)			• CF1=V <sub>DD</sub> or open (External clock mode) • Ta=-10 to +50°C	3.3		0.02	0.56	
				2.5		0.01	0.40	
	IDDHOLD(3)	1	HOLD mode	2.2 to 5.5		3.0	29	μА
			CF1=V <sub>DD</sub> or open (External clock mode)     LVD option selected	2.2 to 3.6		2.3	10	
	IDDHOLD(4)	1	HOLD mode	5.0		3.0	7.3	-
		HOLD mode     CF1=V <sub>DD</sub> or open (External clock mode)     Ta=-10 to +50°C     LVD option selected	CF1=V <sub>DD</sub> or open (External clock mode)			2.3	3.4	
			2.5		2.0	2.9		
		I	yamant da not include oumant that flour			2.0	and intom	

Note9-1: Values of the consumption current do not include current that flows into the output transistors and internal pull-up resistors.

Note9-2: The consumption current values do not include operational current of LVD function if not specified.

#### **F-ROM Programming Characteristics** at $Ta = +10^{\circ}C$ to $+55^{\circ}C$ , $V_{SS}1 = 0V$

Doromotor	Symbol Pin/Remarks		Conditions		Specification				
Parameter	Symbol	Pin/Remarks	Conditions	V <sub>DD</sub> [V]	min	typ	max	unit	
Onboard	IDDFW(1)	V <sub>DD</sub> 1	Only current of the flash block.						
programming				2.2 to 5.5		5	10	mA	
current									
Programming	tFW(1)		Erasing time	0.04- 5.5		20	30	ms	
time	tFW(2)		Programming time	2.2 to 5.5		40	60	μs	

#### **Characteristics of a Sample Main System Clock Oscillation Circuit**

Given below are the characteristics of a sample main system clock oscillation circuit that are measured using a SANYO-designated oscillation characteristics evaluation board and external components with circuit constant values with which the oscillator vendor confirmed normal and stable oscillation.

Table 1 Characteristics of a Sample Main System Clock Oscillator Circuit with a Ceramic Oscillator

• CF oscillation normal amplifier size selected (CFLAMP=0)

#### **■**MURATA

Nominal		0 - 11 - 1		Circuit (	Constant		Operating	Oscillation Stabilization Time		Donata
Frequency	Type	Oscillator Name	C1	C2	Rf	Rd	Voltage Range [V]	typ	max	Remarks
			[pF]	[pF]	[Ω]	[Ω]	[4]	[ms]	[ms]	
12MHz	SMD	CSTCE12M0G52-R0	(10)	(10)	Open	680	2.2 to 5.5	0.1	0.5	
1ZIVII IZ	OIVID	0010E12W0032-10	(10)	(10)	Open	1.0k	2.5 to 5.5	0.1	0.5	
	SMD	CSTCE10M0G52-R0	(10)	(10)	Open	680	2.0 to 5.5	0.1	0.5	
10MHz	SIVID	CSTCL TOWNOGSZ-KO	(10)	(10)	Open	1.0k	2.1 to 5.5	0.1	0.5	
TOWINZ	LEAD	CSTLS10M0G53-B0	(15)	(15)	Open	680	2.2 to 5.5	0.1	0.5	
	LEAD	CSTLSTUMUG53-BU	(15)	(15)	Open	1.0k	2.4 to 5.5	0.1	0.5	
	SMD	CSTCE8M00G52-R0	(40)	(10)	Open	1.0k	1.9 to 5.5	0.1	0.5	
8MHz	SIVID	CSTCE8W00G52-R0	(10)	(10)	Open	1.5k	2.0 to 5.5	0.1	0.5	
OIVITIZ	LEAD	CSTLS8M00G53-B0	(15)	(15)	Open	1.0k	2.0 to 5.5	0.1	0.5	Internal
	LEAD	C31L36W00G33-B0	(15)	(15)	Open	1.5k	2.2 to 5.5	0.1	0.5	C1,C2
	SMD	CSTCR6M00G53-R0	(45)	(45)	Open	1.5k	1.9 to 5.5	0.1	0.5	
6MHz	SIVID	CSTCR6W00G53-R0	(15)	(15)	Open	2.2k	2.0 to 5.5	0.1	0.5	
OIVITIZ	LEAD	CSTLS6M00G53-B0	(45)	(4.5)	Open	1.5k	2.0 to 5.5	0.1	0.5	
	LEAD	CSTLS6WI00G53-B0	(15)	(15)	Open	2.2k	2.1 to 5.5	0.1	0.5	
	SMD	CSTCR4M00G53-R0	(15)	(15)	Open	1.5k	1.8 to 5.5	0.2	0.6	
4041.1-	SIVID	C31 CK4W00G53-K0	(15)	(15)	Open	3.3k	1.9 to 5.5	0.2	0.6	
4MHz	LEAD	1515 00T1011100055	(4.5)	(45)	Open	1.5k	1.8 to 5.5	0.2	0.6	
	LEAD	CSTLS4M00G53-B0	(15)	(15)	Open	3.3k	1.9 to 5.5	0.2	0.6	

• CF oscillation low amplifier size selected (CFLAMP=1)

#### **■**MURATA

Nominal Frequency	Туре	Oscillator Name	Circuit Constant				Operating	Oscillation Stabilization Time		
			C1 [pF]	C2 [pF]	Rf [Ω]	Rd [Ω]	Voltage Range [V]	typ [ms]	max [ms]	Remarks
4MHz	SMD	CSTCR4M00G53-R0	(15)	(15)	Open	1.0k	1.9 to 5.5	0.2	0.6	Internal C1,C2
					Open	2.2k	2.1 to 5.5	0.2	0.6	
		CSTCR4M00G53095-R0	(15)	(15)	Open	1.0k	1.8 to 5.5	0.2	0.6	
					Open	2.2k	1.9 to 5.5	0.2	0.6	
	LEAD	CSTLS4M00G53-B0	(15)	(15)	Open	1.0k	2.0 to 5.5	0.2	0.6	
					Open	2.2k	2.1 to 5.5	0.2	0.6	
		CSTLS4M00G53095-B0	(15)	(15)	Open	1.0k	1.8 to 5.5	0.2	0.6	
					Open	2.2k	1.9 to 5.5	0.2	0.6	

The oscillation stabilization time refers to the time interval that is required for the oscillation to get stabilized after  $V_{DD}$  goes above the operating voltage lower limit (see Figure 3).

- Time till the oscillation gets stabilized after the CPU reset state is released.
- Till the oscillation gets stabilized after the instruction for starting the main clock oscillation circuit is executed.
- Till the oscillation gets stabilized after the HOLD mode is reset. (Notes on the implementation of the oscillator circuit)
- Oscillation is influenced by the circuit pattern layout of printed circuit board. Place the oscillation-related components as close to the CPU chip and to each other as possible with the shortest possible pattern length.
- Keep the signal lines whose state changes suddenly or in which large current flows as far away from the oscillator circuit as possible and make sure that they do not cross one another.
- Be sure to insert a current limiting resistor (Rd) so that the oscillation amplitude never exceeds the input voltage level that is specified as the absolute maximum rating.
- The oscillator circuit constants shown above are sample characteristic values that are measured using the SANYO-designated oscillation evaluation board. Since the accuracy of the oscillation frequency and other characteristics vary according to the board on which the IC is installed, it is recommended that the user consult the resonator vendor for oscillation evaluation of the IC on a user's production board when using the IC for applications that require high oscillation accuracy. For further information, contact your resonator vendor or SANYO Semiconductor sales representative serving your locality.
- It must be noted, when replacing the flash ROM version of a microcontroller with a mask ROM version, that their operating voltage ranges may differ even when the oscillation constant of the external oscillator is the same.

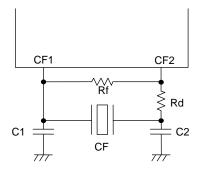
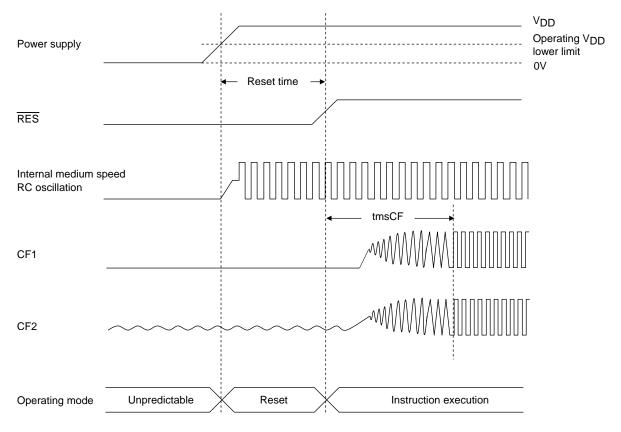


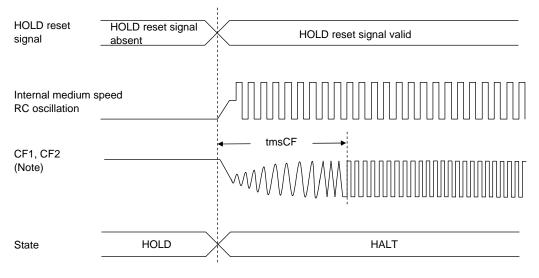
Figure 1 CF Oscillator Circuit



Figure 2 AC Timing Measurement Point



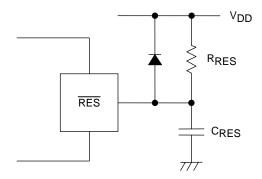
Reset Time and Oscillation Stabilization Time



HOLD Reset Signal and Oscillation Stabilization Time

Note: External oscillation circuit is selected.

Figure 3 Oscillation Stabilization Times



#### Note:

External circuits for reset may vary depending on the usage of POR and LVD. Please refer to the user's manual for more information..

Figure 4 Reset Circuit

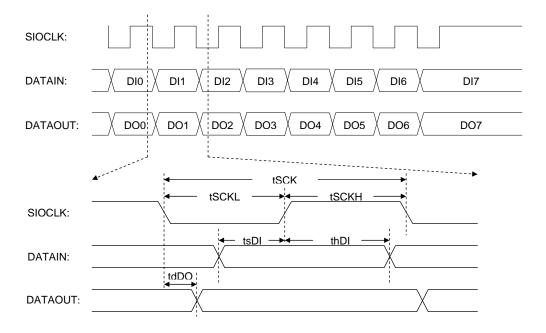


Figure 5 Serial I/O Output Waveforms

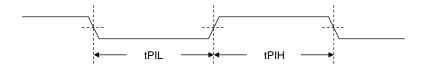


Figure 6 Pulse Input Timing Signal Waveform

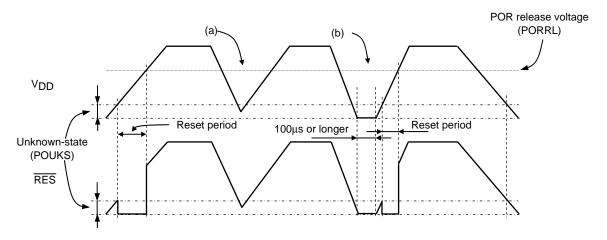


Figure 7 Waveform observed when only POR is used (LVD not used) (RESET pin: Pull-up resistor RRES only)

- The POR function generates a reset only when power is turned on starting at the VSS level.
- No stable reset will be generated if power is turned on again when the power level does not go down to the VSS level as shown in (a). If such a case is anticipated, use the LVD function together with the POR function or implement an external reset circuit.
- A reset is generated only when the power level goes down to the VSS level as shown in (b) and power is turned on again after this condition continues for 100µs or longer.

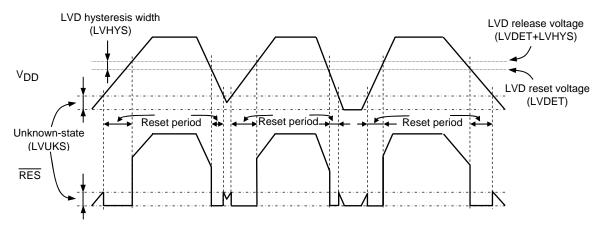


Figure 8 Waveform observed when both POR and LVD functions are used (RESET pin: Pull-up resistor  $R_{RES}$  only)

- Resets are generated both when power is turned on and when the power level lowers.
- A hysteresis width (LVHYS) is provided to prevent the repetitions of reset release and entry cycles near the detection level.

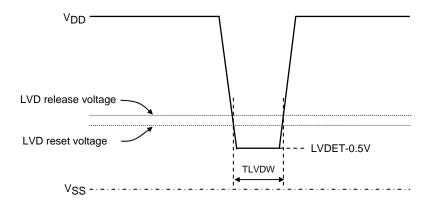


Figure 9 Low voltage detection minimum width (Example of momentary power loss / Voltage variation waveform)

- SANYO Semiconductor Co.,Ltd. assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all SANYO Semiconductor Co.,Ltd. products described or contained herein.
- SANYO Semiconductor Co.,Ltd. strives to supply high-quality high-reliability products, however, any and all semiconductor products fail or malfunction with some probability. It is possible that these probabilistic failures or malfunction could give rise to accidents or events that could endanger human lives, trouble that could give rise to smoke or fire, or accidents that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all SANYO Semiconductor Co.,Ltd. products described or contained herein are controlled under any of applicable local export control laws and regulations, such products may require the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written consent of SANYO Semiconductor Co.,Ltd.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the SANYO Semiconductor Co.,Ltd. product that you intend to use.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production.
- Upon using the technical information or products described herein, neither warranty nor license shall be granted with regard to intellectual property rights or any other rights of SANYO Semiconductor Co.,Ltd. or any third party. SANYO Semiconductor Co.,Ltd. shall not be liable for any claim or suits with regard to a third party's intellectual property rights which has resulted from the use of the technical information and products mentioned above.

This catalog provides information as of November, 2009. Specifications and information herein are subject to change without notice.